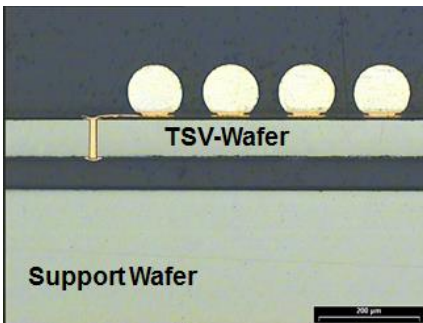


50 µm thin Silicon Interposer Wafer



Silicon Interposer Wafer temporary bonded to Support Wafer

### Fraunhofer Institut für Zuverlässigkeit und Mikrointegration IZM

Gustav-Meyer-Allee 25  
13355 Berlin  
Deutschland

#### Kontakt

Kai Zoschke  
Telefon +49 30 46403-221  
kai.zoschke@izm.fraunhofer.de

Jürgen Grafe  
Telefon +49 351 795572-60  
juergen.grafe@assid.izm.fraunhofer.de

[www.izm.fraunhofer.de](http://www.izm.fraunhofer.de)

## Temporary Wafer Bonding and Thin Wafer Handling

The fabrication of ultra flat devices and stacked system architectures is becoming more important ever. In this context technologies for extreme wafer thinning, thin wafer handling and thin wafer backside processing are imperative to enable 3-dimensional system architectures based on through silicon vias (TSVs). Fraunhofer IZM is focusing its research on temporary wafer support systems based on adhesive wafer to wafer bonding of product and carrier wafers.

Such systems enable wafer thinning as well as reliable support of thin wafers during standard processes like CVD and PVD, lithography, wet and dry etching, electroplating and polymer curing as well as an easy de-bonding of the temporary support wafer from the device wafer after final processing including residue free adhesive removal.

Due to the special design of carrier wafers, adhesives and de-bonding equipment different release mechanisms are possible to finally separate both wafers from each other after the processing was finished. Basic methods are laser release without heat using special designed glass carrier wafers as well as zone bond or slide-off release at elevated temperatures. All methods have their particular pros and cons and are chosen carefully also in correlation with the corresponding kind of

customer wafer to be bonded and de-bonded with them.

Based on the configuration of the customer wafer (surface materials and topography, thickness, kind of processes to be applied) as well as the subsequent sample treatment like second level assembly of components, the most suitable handling concept and wafer support system can be used.

Even the cascaded use of the same support system or the combination of different style temporary wafer handling systems is possible to enable thin wafer transfer bonding.

The available temporary wafer support systems enable the following process scenarios:

- Extreme thinning and stress relief of silicon wafers with different type of front side topography
- Back side processing of thin wafers with different front side topography including isolation / passivation, high density redistribution, contact formation
- Multiple thin wafer transfer to enable alternated front and backside processing
- Chip to thin wafer assembly
- Temporary support of thin chips during assembly
- Stacking of thin components at wafer level and component level